

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
NAGAYAMA, KENICHI

Examiner

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Art Unit

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Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0199111	10-2003	Hamamura et al.	438/17
*	B	US-2001/0041269	11-2001	Berntsen et al.	428/690
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	O					
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**NON-PATENT DOCUMENTS**

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